

IGBT module

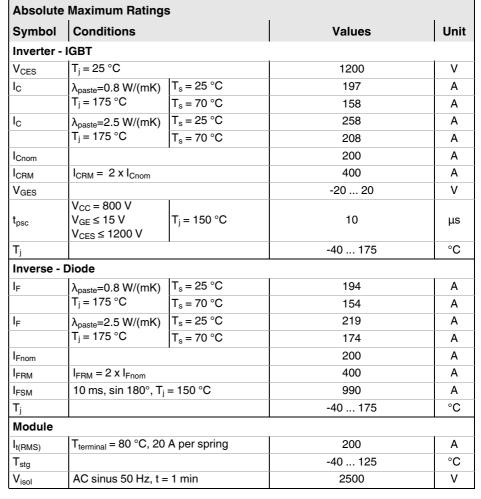
SKiiP 26GB12F4V1

Features

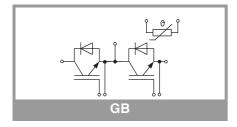
- Fast Trench 4 IGBTs
- Robust and soft freewheeling diodes in CAL technology
- Highly reliable spring contacts for electrical connections
- UL recognised: File no. E63532
- NTC T-Sensor

Remarks

- Max. case temperature limited to T_C= 125°C
- Product reliability results valid for T_j≤150°C (recommended T_{j,op}=-40...+150°C)



Characteristics										
Symbol	Conditions		min.	typ.	max.	Unit				
Inverter - IGBT										
Vo	I _C = 200 A	T _j = 25 °C		2.05	2.42	V				
	V _{GE} = 15 V chiplevel	T _j = 150 °C		2.59	2.96	V				
V _{CE0}	chiplevel	T _j = 25 °C		1.10	1.28	V				
		T _j = 150 °C		0.95	1.13	V				
r _{CE}	<u> </u>	T _j = 25 °C		4.8	5.7	mΩ				
		T _j = 150 °C		8.2	9.2	mΩ				
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 7.6$ mA		5.2	5.8	6.4	V				
I _{CES}	$V_{GE} = 0 \text{ V}, V_{CE} = 12$	00 V, T _j = 25 °C		0.1	0.3	mA				
C _{ies}	V _{CE} = 25 V V _{GE} = 0 V	f = 1 MHz		12.30		nF				
C _{oes}		f = 1 MHz		0.81		nF				
C _{res}		f = 1 MHz		0.69		nF				
Q_G	V _{GE} = - 8 V+ 15 V			1134		nC				
R _{Gint}	T _j = 25 °C			3.8		Ω				
t _{d(on)}	$I_{\rm C} = 200 {\rm A}$	T _j = 150 °C		167		ns				
t _r		T _j = 150 °C		52		ns				
E _{on}		T _j = 150 °C		16.8		mJ				
t _{d(off)}		T _j = 150 °C		414		ns				
t _f				52		ns				
E _{off}	V _{GE} = +15/-15 V	T _j = 150 °C		16.3		mJ				
R _{th(j-s)}	per IGBT, λ _{paste} =0.8 W/(mK)			0.25		K/W				
R _{th(j-s)}	per IGBT, λ _{paste} =2.5 W/(mK)			0.16		K/W				





MiniSKiiP® 2 Dual

IGBT module

SKiiP 26GB12F4V1

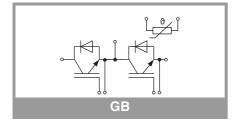
Features

- Fast Trench 4 IGBTs
- Robust and soft freewheeling diodes in CAL technology
- Highly reliable spring contacts for electrical connections
- UL recognised: File no. E63532
- NTC T-Sensor

Remarks

- Max. case temperature limited to T_C = 125°C
- Product reliability results valid for $T_j \le 150^{\circ}\text{C}$ (recommended $T_{j,\text{op}} = -40... + 150^{\circ}\text{C}$)

Characteristics										
Symbol	Conditions		min.	typ.	max.	Unit				
Inverse - Diode										
$V_F = V_{EC}$	I _F = 200 A	T _j = 25 °C		2.20	2.52	٧				
	V _{GE} = 0 V chiplevel	T _j = 150 °C		2.15	2.47	V				
V _{F0}	chiplevel	$T_j = 25 ^{\circ}C$		1.30	1.50	V				
		T _j = 150 °C		0.90	1.10	V				
r _F	chiplevel	T _j = 25 °C		4.5	5.1	mΩ				
	Chipicvei	T _j = 150 °C		6.3	6.9	mΩ				
I _{RRM}	$I_F = 200 \text{ A}$ $di/dt_{off} = 3840 \text{ A/}\mu\text{s}$ $V_{GE} = -15 \text{ V}$ $V_{CC} = 600 \text{ V}$	T _j = 150 °C		189		Α				
Q_{rr}		T _j = 150 °C		28.7		μC				
E _{rr}		T _j = 150 °C		11.7		mJ				
R _{th(j-s)}	per Diode, λ _{paste} =0.8 W/(mK)			0.34		K/W				
R _{th(j-s)}	per Diode, λ _{paste} =2.5 W/(mK)			0.28		K/W				
Module										
L _{CE}				20		nΗ				
Ms	to heat sink		2		2.5	Nm				
w				50		g				
Temperature Sensor										
R ₁₀₀	T_c =100°C (R ₂₅ =5 kΩ)		493 ± 5%			Ω				
B _{25/85}	$R_{(T)} = R_{25} * \exp[B_{25/85} * (1/T-1/298)], [T] = K$			3420		K				



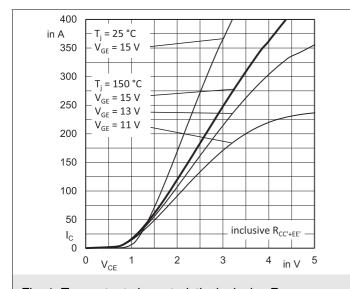


Fig. 1: Typ. output characteristic, inclusive $R_{\text{CC'+}\,\text{EE'}}$

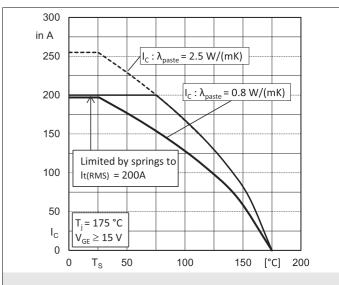


Fig. 2: Rated current vs. temperature $I_C = f(T_S)$

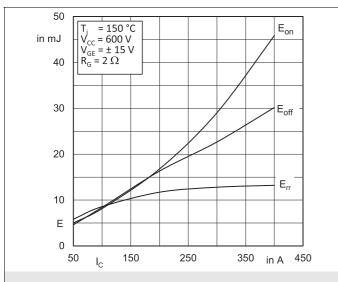


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

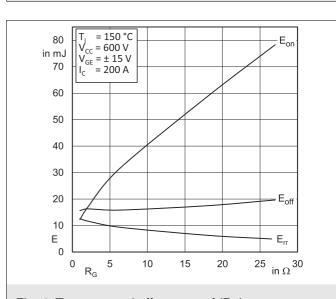


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

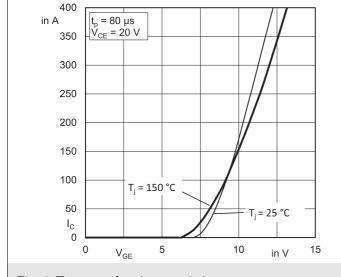


Fig. 5: Typ. transfer characteristic

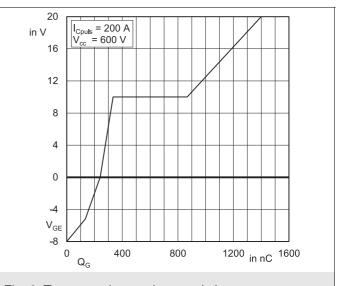


Fig. 6: Typ. gate charge characteristic

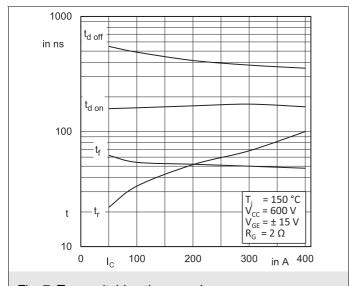


Fig. 7: Typ. switching times vs. I_C

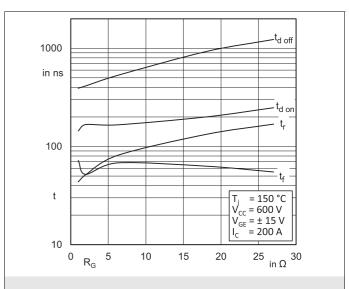


Fig. 8: Typ. switching times vs. gate resistor R_{G}

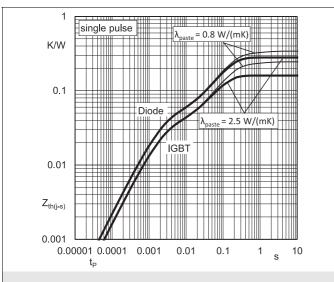


Fig. 9: Transient thermal impedance of IGBT and Diode

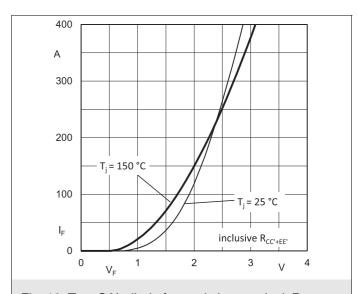


Fig. 10: Typ. CAL diode forward charact., incl. $R_{CC'+\,EE'}$

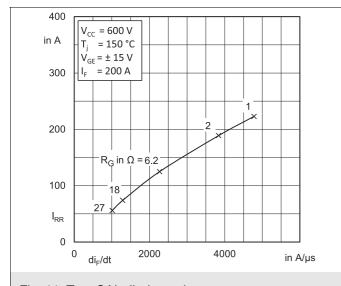


Fig. 11: Typ. CAL diode peak reverse recovery current

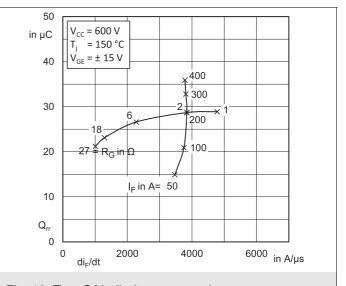
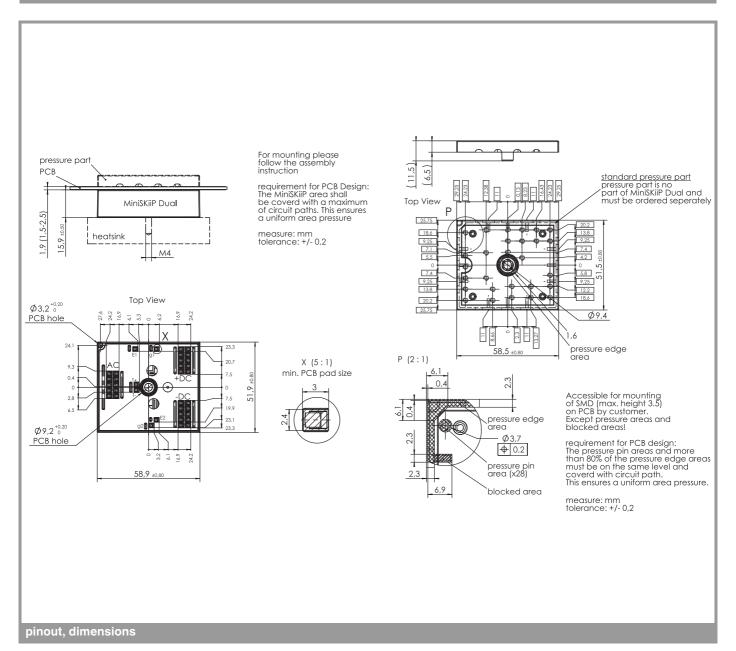
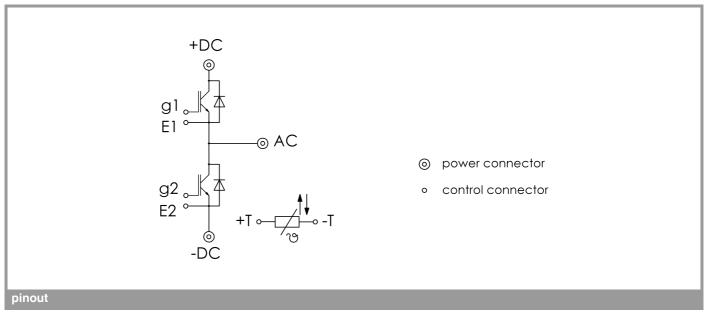


Fig. 12: Typ. CAL diode recovery charge





This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

*IMPORTANT INFORMATION AND WARNINGS

The specifications of SEMIKRON products may not be considered as guarantee or assurance of product characteristics ("Beschaffenheitsgarantie"). The specifications of SEMIKRON products describe only the usual characteristics of products to be expected in typical applications, which may still vary depending on the specific application. Therefore, products must be tested for the respective application in advance. Application adjustments may be necessary. The user of SEMIKRON products is responsible for the safety of their applications embedding SEMIKRON products and must take adequate safety measures to prevent the applications from causing a physical injury, fire or other problem if any of SEMIKRON products become faulty. The user is responsible to make sure that the application design is compliant with all applicable laws, regulations, norms and standards. Except as otherwise explicitly approved by SEMIKRON in a written document signed by authorized representatives of SEMIKRON, SEMIKRON products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury. No representation or warranty is given and no liability is assumed with respect to the accuracy, completeness and/or use of any information herein, including without limitation, warranties of non-infringement of intellectual property rights of any third party. SEMIKRON does not assume any liability arising out of the applications or use of any product; neither does it convey any license under its patent rights, copyrights, trade secrets or other intellectual property rights, nor the rights of others. SEMIKRON makes no representation or warranty of non-infringement or alleged non-infringement of intellectual property rights of any third party which may arise from applications. Due to technical requirements our products may contain dangerous substances. For information on the types in question please contact the nearest SEMIKRON sales office. This document supersedes and replaces all information previously supplied and may be superseded by updates. SEMIKRON reserves the right to make changes.

6 Rev. 2.0 – 19.10.2017 © by SEMIKRON